

Silicon Carbide (SiC) Cascode JFET - EliteSiC, Power N-Channel, TO247-4LH, 1200 V, 9.1 mohm

UF4SC120009K4SH

Description

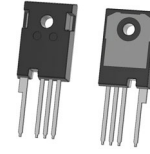
The UF4SC120009K4SH is a 1200 V, 9.1 mΩ G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows use of off-the-shelf gate drivers hence requiring minimal redesign when replacing Si IGBTs, Si superjunction devices or SiC MOSFETs. Available in the TO247-4LH HV package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

Features

- On-resistance $R_{DS(on)}$, of 9.1 mΩ (typ)
- Operating Temperature of 175 °C
- Excellent Reverse Recovery: Q_{rr} = 615 nC
- Low Body Diode V_{FSD} : 1.09 V
- Low Gate Charge: Q_G = 168 nC
- Threshold Voltage $V_{G(th)}$: 4.7 V (typ) Allowing 0 to 15 V Drive
- Low Intrinsic Capacitance
- Kelvin Source Pin for Optimized Switching Performance
- HV Package With 8 mm D-S Creepage Distance
- ESD Protected, HBM Class 2 and CDM Class C3
- This Device is Pb-Free, Halogen Free and is RoHS Compliant

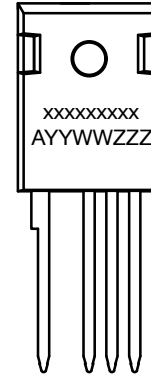
Typical Applications

- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- Induction Heating



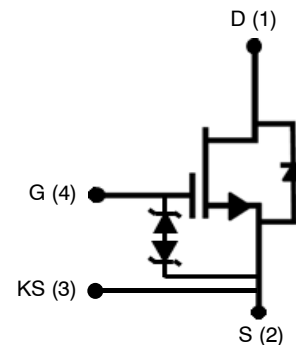
TO247-4LH
CASE 340CV

MARKING DIAGRAM



XXXXXXXX = Specific Device Number
A = Assembly Location
YY = Year
WW = Work Week
ZZZ = Lot ID

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

UF4SC120009K4SH

MAXIMUM RATINGS

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	V_{DS}		1200	V
Gate-source Voltage	V_{GS}	DC	-20 to +20	V
		AC ($f > 1$ Hz)	-25 to +25	V
Continuous Drain Current (Note 1)	I_D	$T_C < 100$ °C	120	A
Pulsed Drain Current (Note 2)	I_{DM}	$T_C = 25$ °C	550	A
Single Pulsed Avalanche Energy (Note 3)	E_{AS}	$L = 15$ mH, $I_{AS} = 6.5$ A	317	mJ
Power Dissipation	P_{tot}	$T_C = 25$ °C	750	W
SiC FET dv/dt Ruggedness	dv/dt	$V_{DS} < 800$ V	150	V/ns
Maximum Junction Temperature	$T_{J,max}$		175	°C
Operating and Storage Temperature	T_J, T_{STG}		-55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	T_L		250	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Limited by bondwires.
- Pulse width t_p limited by $T_{J,max}$
- Starting $T_J = 25$ °C

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		–	0.15	0.20	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = +25$ °C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
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TYPICAL PERFORMANCE – STATIC

Drain-source Breakdown Voltage	BV_{DS}	$V_{GS} = 0$ V, $I_D = 1$ mA	1200	–	–	V
Total Drain Leakage Current	I_{DSS}	$V_{DS} = 1200$ V, $V_{GS} = 0$ V, $T_J = 25$ °C	–	5	300	μA
		$V_{DS} = 1200$ V, $V_{GS} = 0$ V, $T_J = 175$ °C	–	56	–	
Total Gate Leakage Current	I_{GSS}	$V_{DS} = 0$ V, $T_J = 25$ °C, $V_{GS} = -20$ V/ +20 V	–	6	20	μA
Drain-source On-resistance	$R_{DS(on)}$	$V_{GS} = 12$ V, $I_D = 80$ A, $T_J = 25$ °C	–	9.1	10.6	mΩ
		$T_J = 125$ °C	–	16.9	–	
		$T_J = 175$ °C	–	23.3	–	
Gate Threshold Voltage	$V_{G(th)}$	$V_{DS} = 5$ V, $I_D = 10$ mA	4	4.7	6	V
Gate Resistance	R_G	$f = 1$ MHz, open drain	–	0.8	1.5	Ω

TYPICAL PERFORMANCE – REVERSE DIODE

Diode Continuous Forward Current	I_S	$T_C < 100$ °C	–	–	120	A
Diode Pulse Current	$I_{S,pulse}$	$T_C = 25$ °C	–	–	550	A
Forward Voltage	V_{FSD}	$V_{GS} = 0$ V, $I_F = 40$ A, $T_J = 25$ °C	–	1.09	1.45	V
		$V_{GS} = 0$ V, $I_S = 40$ A, $T_J = 175$ °C	–	1.31	–	
Reverse Recovery Charge	Q_{rr}	$V_{DS} = 800$ V, $I_S = 80$ A, $V_{GS} = 0$ V, $R_{G,EXT} = 2$ Ω, $di/dt = 2600$ A/μs, $T_J = 25$ °C	–	615	–	nC
Reverse Recovery Time	t_{rr}	$T_J = 25$ °C	–	48	–	ns
Reverse Recovery Charge	Q_{rr}	$V_{DS} = 800$ V, $I_S = 80$ A, $V_{GS} = 0$ V, $R_{G,EXT} = 2$ Ω, $di/dt = 2600$ A/μs, $T_J = 150$ °C	–	724	–	nC
Reverse Recovery Time	t_{rr}	$T_J = 150$ °C	–	55	–	ns

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ELECTRICAL CHARACTERISTICS (T_J = +25 °C unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
TYPICAL PERFORMANCE – DYNAMIC						
Input Capacitance	C _{iss}	V _{DS} = 800 V, V _{GS} = 0 V, f = 100 kHz	–	7218	–	pF
Output Capacitance	C _{oss}		–	204	–	
Reverse Transfer Capacitance	C _{rss}		–	0.2	–	
Effective Output Capacitance, Energy Related	C _{oss(er)}	V _{DS} = 0 V to 800 V, V _{GS} = 0 V	–	265	–	pF
Effective Output Capacitance, Time Related	C _{oss(tr)}		–	528	–	pF
C _{oss} Stored Energy	E _{oss}	V _{DS} = 800 V, V _{GS} = 0 V	–	85	–	μJ
Total Gate Charge	Q _G	V _{DS} = 800 V, I _D = 80 A, V _{GS} = 0 V to 15 V	–	168	–	nC
Gate-drain Charge	Q _{GD}		–	28	–	
Gate-source Charge	Q _{GS}		–	50	–	
Turn-on Delay Time	t _{d(on)}	(Notes 4 and 5) V _{DS} = 800 V, I _D = 80 A, Gate Driver = 0 V to +15 V, R _{G,EXT} = 2 Ω, Inductive Load, FWD: Same Device With V _{GS} = 0 V, R _G = 2 Ω, RC Snubber: R _S = 5 Ω, C _S = 440 pF, T _J = 25 °C	–	40	–	ns
Rise Time	t _r		–	37	–	
Turn-off Delay Time	t _{d(off)}		–	81	–	
Fall Time	t _f		–	16	–	
Turn-on Energy Including R _S Energy	E _{ON}		–	1656	–	μJ
Turn-off Energy Including R _S Energy	E _{OFF}		–	255	–	
Total Switching Energy Including R _S Energy	E _{TOTAL}		–	1911	–	
Snubber R _S Energy During Turn-on	E _{RS_ON}		–	19.5	–	
Snubber R _S Energy During Turn-off	E _{RS_OFF}		–	76.5	–	
Turn-on Delay Time	t _{d(on)}	(Notes 4 and 5) V _{DS} = 800 V, I _D = 80 A, Gate Driver = 0 V to +15 V, R _{G,EXT} = 2 Ω, Inductive Load, FWD: Same Device With V _{GS} = 0 V, R _G = 2 Ω, RC Snubber: R _S = 5 Ω, C _S = 440 pF, T _J = 150 °C	–	36	–	ns
Rise Time	t _r		–	42	–	
Turn-off Delay Time	t _{d(off)}		–	85	–	
Fall Time	t _f		–	18	–	
Turn-on Energy Including R _S Energy	E _{ON}		–	1940	–	μJ
Turn-off Energy Including R _S Energy	E _{OFF}		–	283	–	
Total Switching Energy Including R _S Energy	E _{TOTAL}		–	2223	–	
Snubber R _S Energy During Turn-on	E _{RS_ON}		–	18	–	
Snubber R _S Energy During Turn-off	E _{RS_OFF}		–	71	–	
Turn-on Delay Time	t _{d(on)}	(Notes 5 and 6) V _{DS} = 800 V, I _D = 80 A, Gate Driver = 0 V to +15 V, R _{G,EXT} = 2 Ω, Inductive Load, FWD: UJ3D1250K2, RC Snubber: R _S = 5 Ω, C _S = 440 pF, T _J = 25 °C	–	40	–	ns
Rise Time	t _r		–	30	–	
Turn-off Delay Time	t _{d(off)}		–	81	–	
Fall Time	t _f		–	13	–	
Turn-on Energy Including R _S Energy	E _{ON}		–	918	–	μJ
Turn-off Energy Including R _S Energy	E _{OFF}		–	250	–	
Total Switching Energy Including R _S Energy	E _{TOTAL}		–	1168	–	
Snubber R _S Energy During Turn-on	E _{RS_ON}		–	18	–	
Snubber R _S Energy During Turn-off	E _{RS_OFF}		–	113	–	

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ELECTRICAL CHARACTERISTICS ($T_J = +25\text{ }^{\circ}\text{C}$ unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
TYPICAL PERFORMANCE – DYNAMIC						
Turn-on Delay Time	$t_{d(on)}$	(Notes 5 and 6) $V_{DS} = 800\text{ V}$, $I_D = 80\text{ A}$, Gate Driver = 0 V to $+15\text{ V}$, $R_{G,EXT} = 2\text{ }\Omega$, Inductive Load, FWD: UJ3D1250K2, RC Snubber: $R_S = 5\text{ }\Omega$, $C_S = 440\text{ pF}$, $T_J = 150\text{ }^{\circ}\text{C}$	–	36	–	ns
Rise Time	t_r		–	34	–	
Turn-off Delay Time	$t_{d(off)}$		–	85	–	
Fall Time	t_f		–	14	–	
Turn-on Energy Including R_S Energy	E_{ON}		–	1040	–	μJ
Turn-off Energy Including R_S Energy	E_{OFF}		–	280	–	
Total Switching Energy Including R_S Energy	E_{TOTAL}		–	1320	–	
Snubber R_S Energy During Turn-on	E_{RS_ON}		–	16.5	–	
Snubber R_S Energy During Turn-off	E_{RS_OFF}		–	110	–	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Measured with the switching test circuit in Figure 26.

5. In this table, the switching energies (turn-on energy, turn-off energy and total energy) presented include the device RC snubber energy losses.

6. Measured with the switching test circuit in Figure 26 where the high-side switch Q1 is replaced with the diode and no RC snubber is applied for the diode.

TYPICAL PERFORMANCE DIAGRAMS

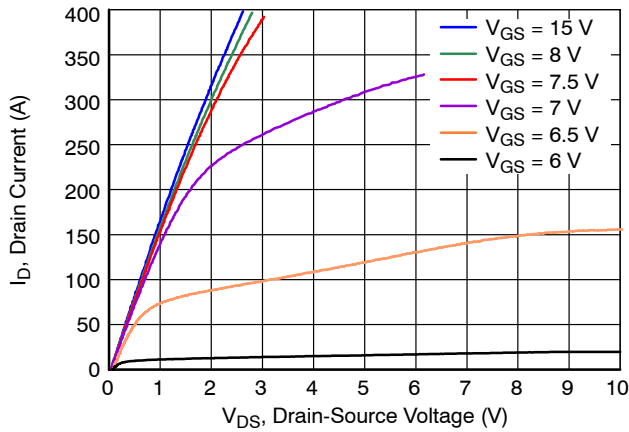


Figure 1. Typical Output Characteristics at $T_J = -55\text{ }^{\circ}\text{C}$, $t_p < 250\text{ }\mu\text{s}$

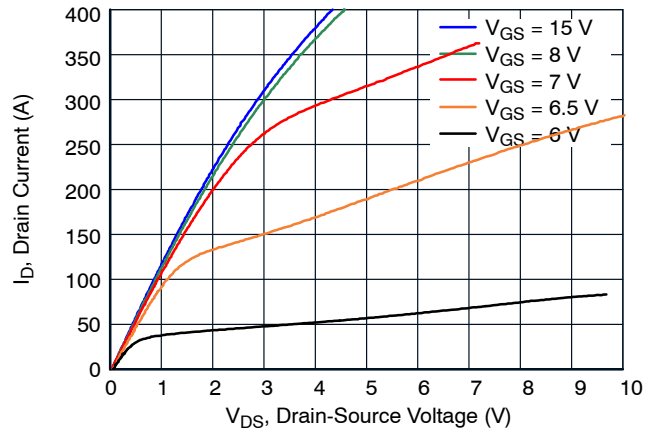


Figure 2. Typical Output Characteristics at $T_J = 25\text{ }^{\circ}\text{C}$, $t_p < 250\text{ }\mu\text{s}$

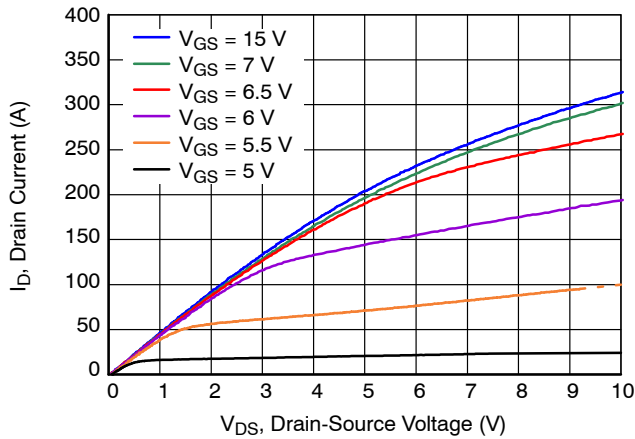


Figure 3. Typical Output Characteristics at $T_J = 175\text{ }^{\circ}\text{C}$, $t_p < 250\text{ }\mu\text{s}$

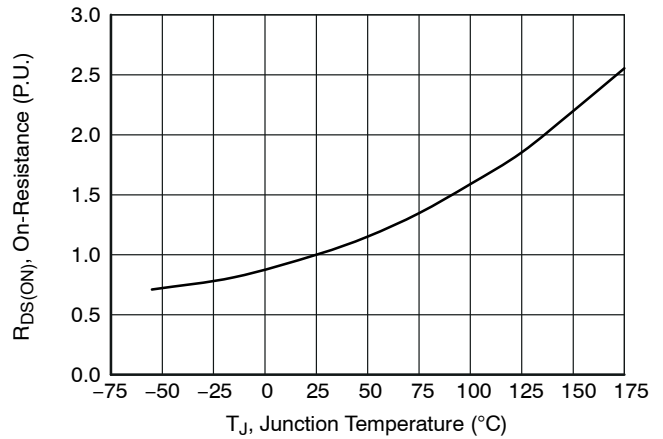


Figure 4. Normalized On-Resistance vs. Temperature at $V_{GS} = 12\text{ V}$ and $I_D = 80\text{ A}$

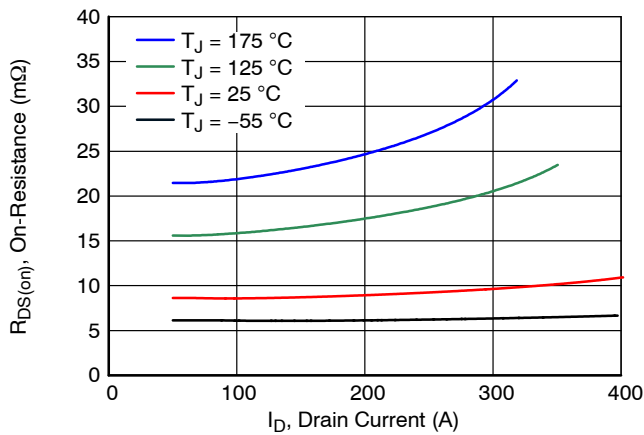


Figure 5. Typical Drain-Source On-Resistances at $V_{GS} = 12\text{ V}$

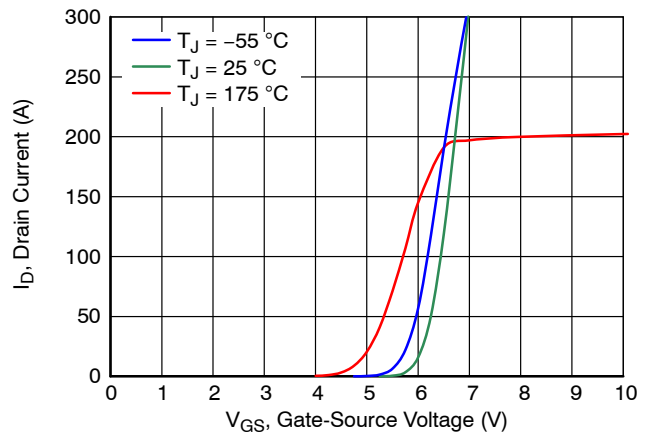


Figure 6. Typical Transfer Characteristics at $V_{DS} = 5\text{ V}$

TYPICAL PERFORMANCE DIAGRAMS (continued)

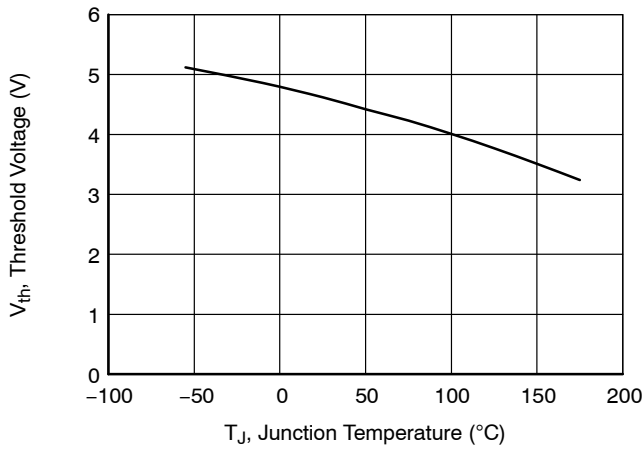


Figure 7. Threshold Voltage vs. Junction Temperature at $V_{DS} = 5\text{ V}$ and $I_D = 10\text{ mA}$

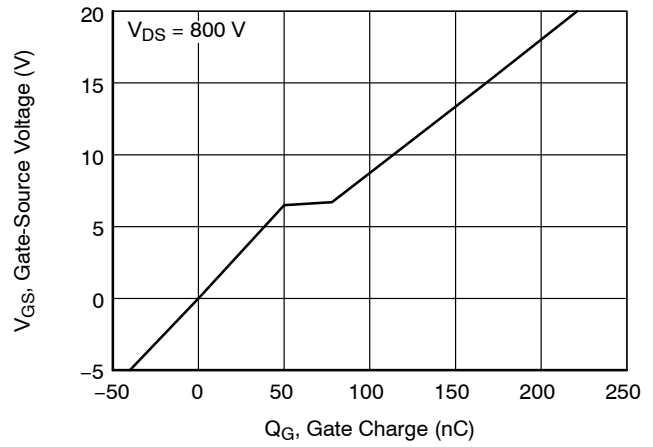


Figure 8. Typical Gate Charge at $I_D = 80\text{ A}$

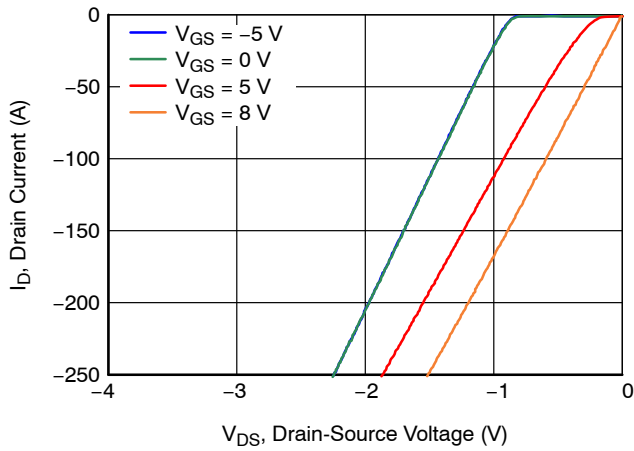


Figure 9. 3rd Quadrant Characteristics at $T_J = -55\text{ °C}$

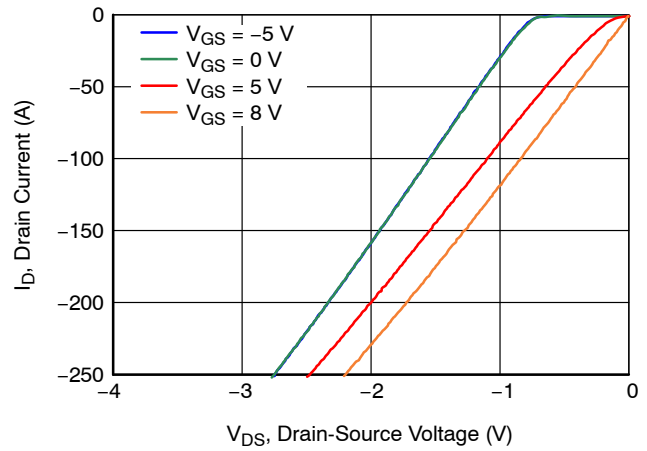


Figure 10. 3rd Quadrant Characteristics at $T_J = 25\text{ °C}$

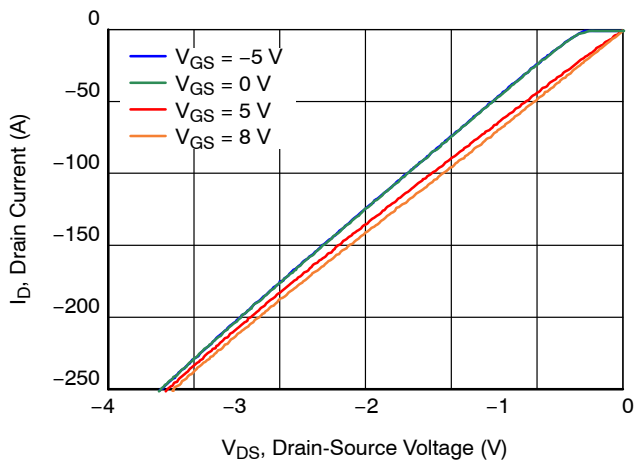


Figure 11. 3rd Quadrant Characteristics at $T_J = 175\text{ °C}$

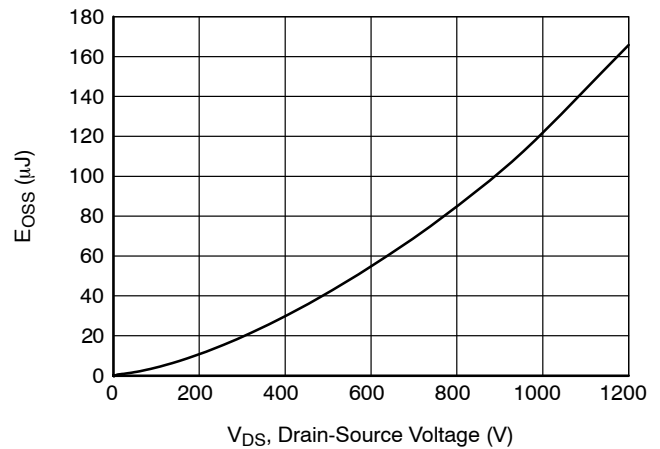


Figure 12. Typical Stored Energy in C_{OSS} at $V_{GS} = 0\text{ V}$

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TYPICAL PERFORMANCE DIAGRAMS (continued)

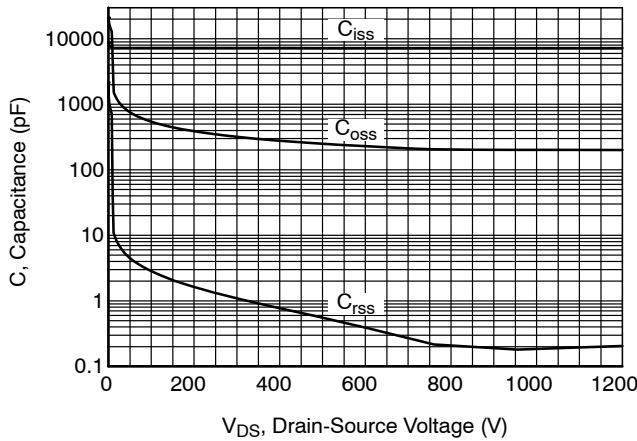


Figure 13. Typical Capacitances at
 $f = 100 \text{ kHz}$ and $V_{GS} = 0 \text{ V}$

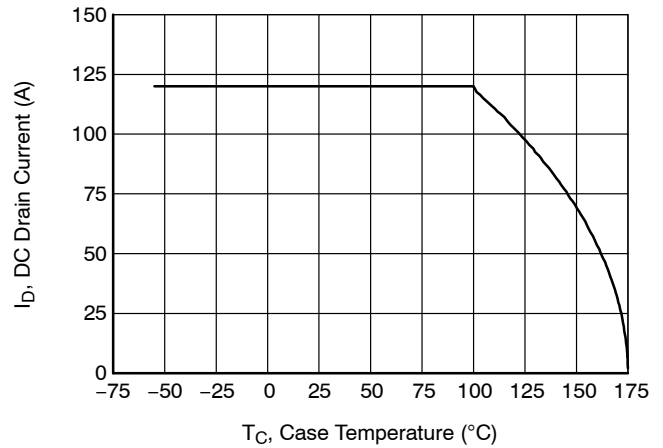


Figure 14. DC Drain Current Derating

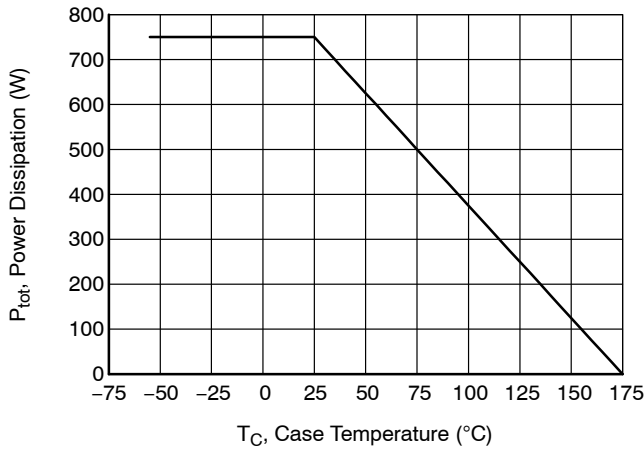


Figure 15. Total Power Dissipation

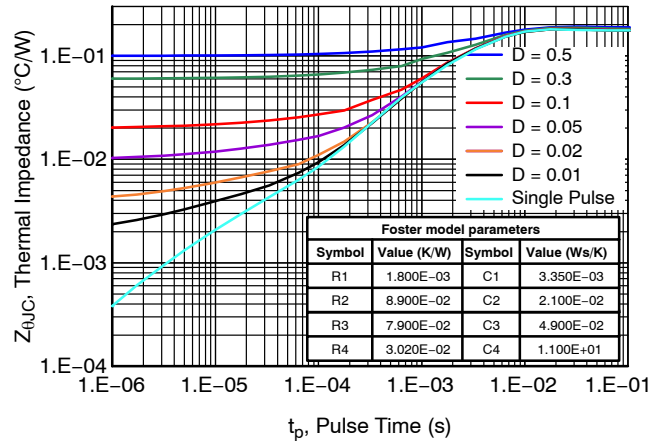


Figure 16. Maximum Transient Thermal Impedance

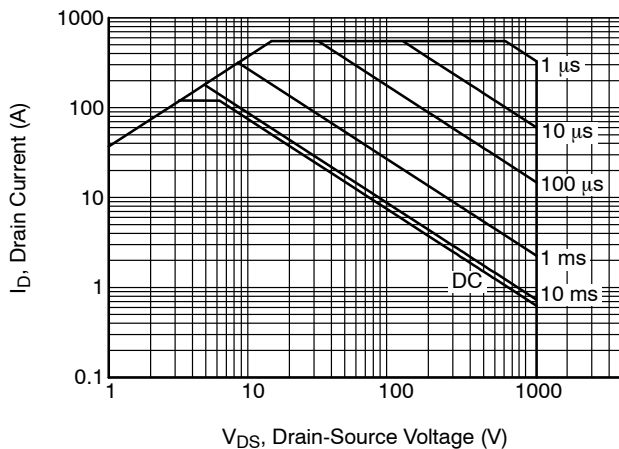


Figure 17. Safe Operation Area at
 $T_C = 25 \text{ °C}$, $D = 0$, Parameter t_p

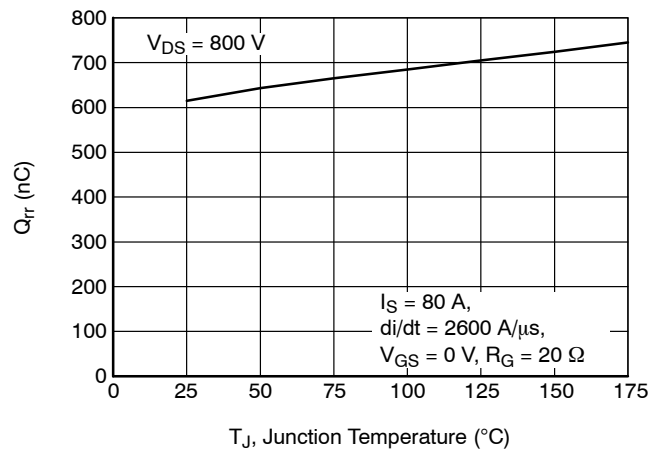


Figure 18. Reverse Recovery Charge Q_{rr}
vs. Junction Temperature

TYPICAL PERFORMANCE DIAGRAMS (continued)

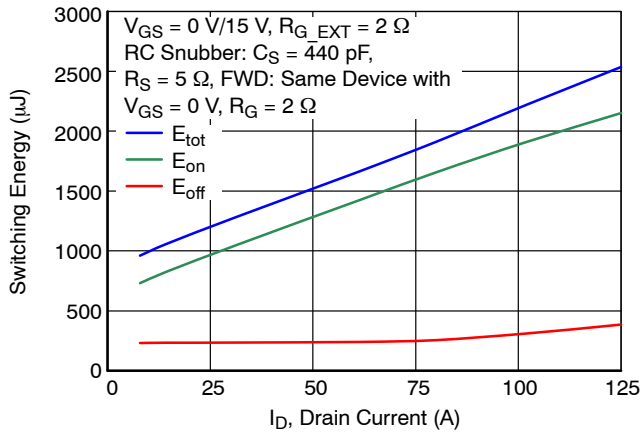


Figure 19. Clamped Inductive Switching Energy vs. Drain Current at $V_{DS} = 800 \text{ V}$ and $T_J = 25^\circ \text{C}$

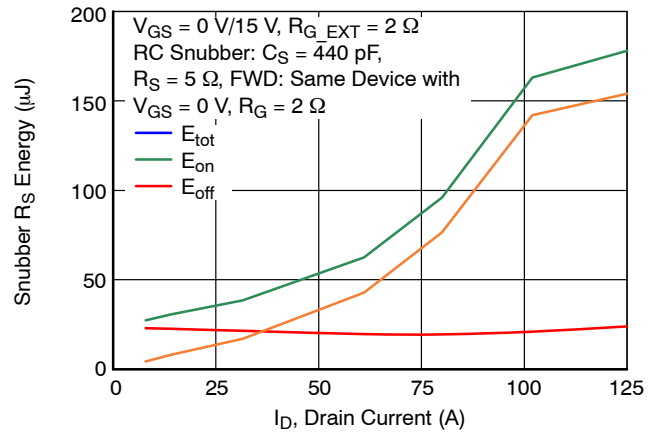


Figure 20. RC Snubber Energy Loss vs. Drain Current at $V_{DS} = 800 \text{ V}$ and $T_J = 25^\circ \text{C}$

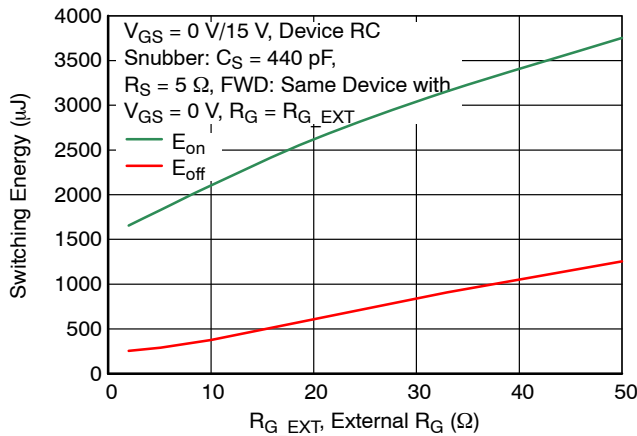


Figure 21. Clamped Inductive Switching Energy vs. R_{G_EXT} at $V_{DS} = 800 \text{ V}$, $I_D = 80 \text{ A}$ and $T_J = 25^\circ \text{C}$

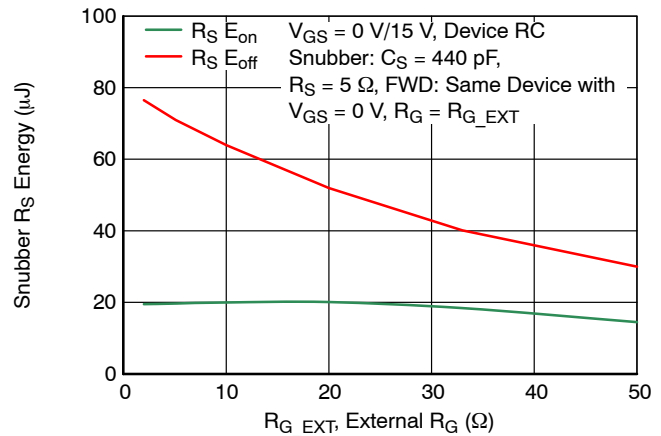


Figure 22. RC Snubber Energy Loss vs. R_{G_EXT} at $V_{DS} = 800 \text{ V}$, $I_D = 80 \text{ A}$ and $T_J = 25^\circ \text{C}$

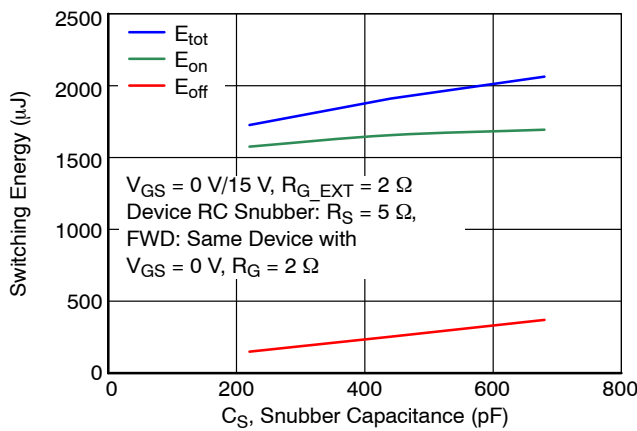


Figure 23. Clamped Inductive Switching Energies vs. Snubber Capacitance C_S at $V_{DS} = 800 \text{ V}$, $I_D = 80 \text{ A}$ and $T_J = 25^\circ \text{C}$

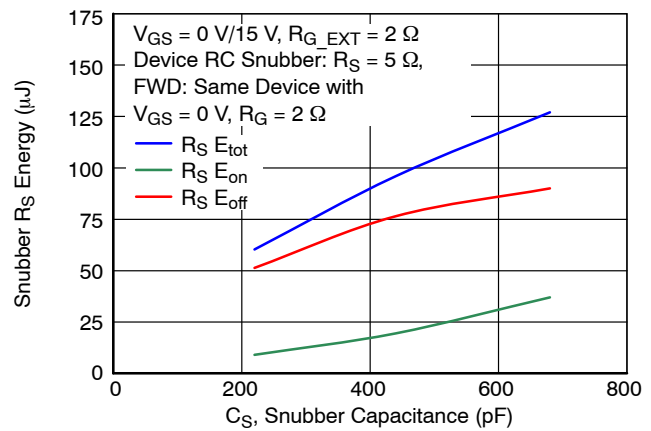


Figure 24. RC Snubber Energy Losses vs. Snubber Capacitance at $V_{DS} = 800 \text{ V}$, $I_D = 80 \text{ A}$ and $T_J = 25^\circ \text{C}$

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TYPICAL PERFORMANCE DIAGRAMS (continued)

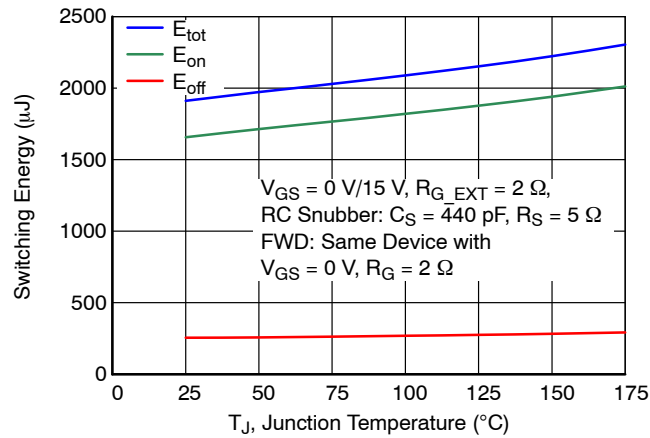


Figure 25. Clamped Inductive Switching Energy vs. Junction Temperature at $V_{\text{DS}} = 800 \text{ V}$, $I_{\text{D}} = 80 \text{ A}$

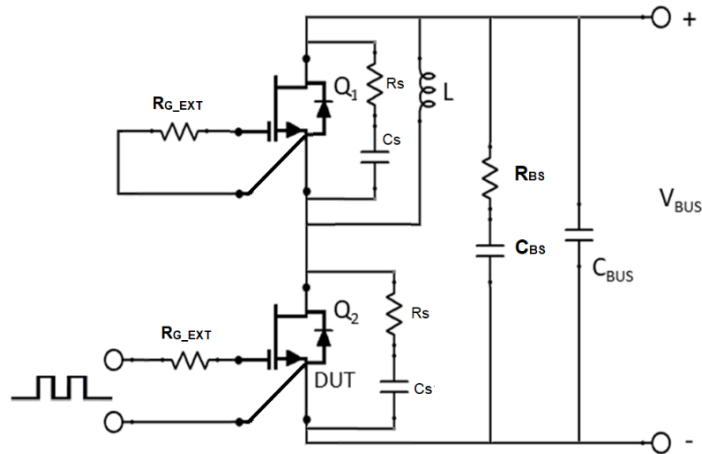
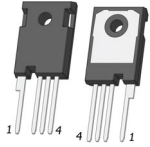


Figure 26. Schematic of the Half-Bridge Mode Switching Test Circuit. Note, a Bus RC Snubber ($R_{\text{BS}} = 5 \Omega$, $C_{\text{BS}} = 100 \text{ nF}$) Is Used To Reduce the Power Loop High Frequency Oscillations

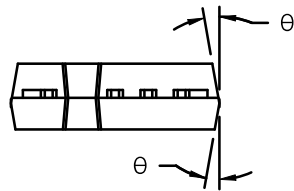
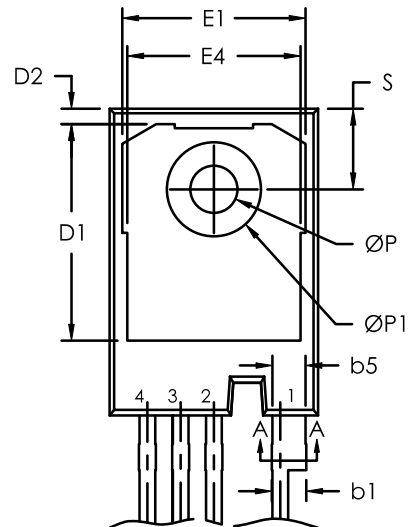
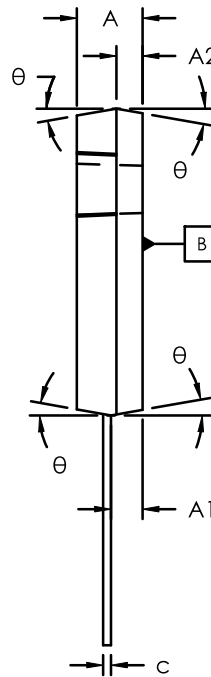
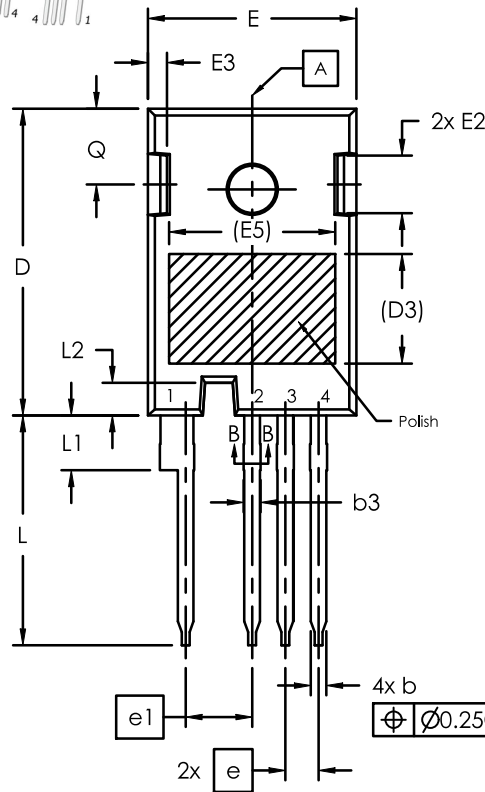
ORDERING INFORMATION

Part Number	Marking	Package	Shipping [†]
UF4SC120009K4SH	UF4SC120009K4SH	TO247-4LH (Pb-Free, Halogen Free)	600 / Tube

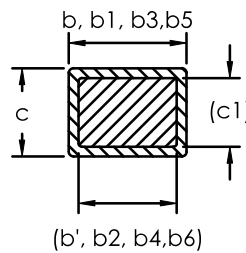
[†] For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).


TO247-4LH 15.94x23.45x5.02, 2.54P
CASE 340CV
ISSUE B

DATE 16 APR 2025



Section A-A, B-B


NOTE:

1. Dimensioning and tolerancing as per ASME Y14.5 - 2018
2. Controlling Dimensions = Millimeters
3. Dimensions D and E does not include MOLD FLASH
4. Thermal pad contour optional within dimensions D1 and E1
5. Lead finish uncontrolled in L1
6. ØP to have a max draft angle of 1.5° to the top with MAX. hole diameter of 3.91mm

TO247-4LH			
	mm		
SYM	MIN	NOM	MAX
A	4.80	5.02	5.21
A1	2.21	2.41	2.61
A2	1.80	2.00	2.20
b	1.06	1.20	1.36
b'	1.07	1.20	1.28
b1	2.33	2.53	2.94
b3	1.07	1.20	1.60
b5	2.40	2.54	2.69
b6	2.39	2.53	2.64
c	0.51	0.60	0.75
c'	0.51	0.60	0.72
D	23.30	23.45	23.60
D1	16.25	16.55	17.65
D2	0.95	1.19	1.25
D3	8.38 REF		
E	15.74	15.94	16.14
E1	13.10	14.02	14.32
E2	3.68	4.40	5.10
E3	1.00	1.45	1.90
E4	12.38	13.26	13.43
E5	12.70 REF		
e	2.54 BSC		
e1	5.08 BSC		
L	17.27	17.57	17.87
L1	3.97	4.19	4.39
L2	2.35	2.50	2.65
ØP	3.40	3.61	3.80
ØP1	7.19 REF		
Q	5.49	5.79	6.09
S	6.04	6.17	6.30
θ	10°		

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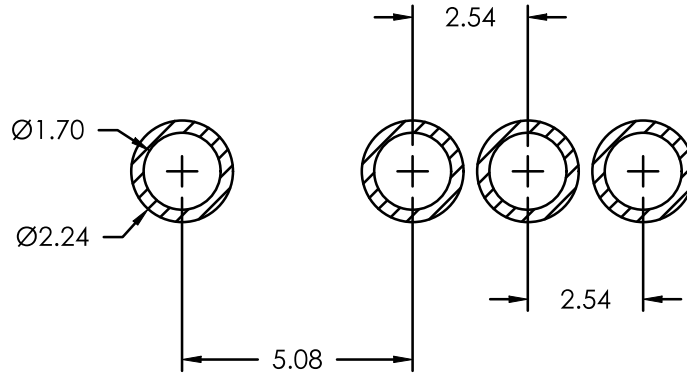
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RECOMMENDED PCB THROUGH HOLE



NOTE: LAND PATTERN AND THROUGH HOLE DIMENSIONS SERVE ONLY AS AN INITIAL GUIDE.
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